

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250290US2RD		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroaki NAKAI, et al.			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AK						
	AL						
	AM						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/AA/	AN	11-328365	11/30/99	Japan	 x		
/AA/	AO	2000-293693	10/20/00	Japan	 x		
	AP						
	AQ						
	AR						
	AS						
	AT						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
/AA/	AU	Martin A. FISCHLER, et al. "Random Sample Consensus: A Paradigm for Model Fitting with Applications to Image Analysis and Automated Cartography", COMMUNICATIONS OF THE ACM, Vol. 24, No. 6, 1981, pgs. 381-395					
/AA/	AV	Hiroaki SAKOE, et al. "Dynamic Programming Algorithm Optimization for Spoken Word Recognition", IEEE TRANSACTIONS ON ACOUSTICS, SPEECH, AND SIGNAL PROCESSING, Vol. 26, No. 1, 1978, pgs. 43-49					
/AA/	AW	Naoki CHIBA, et al. "A Tracker for Broken and Closely-Spaced Lines", TRANS. OF IEICE D-II, Vol. J81-D-II, No. 8, 1998, pgs. 1744-1751					
/AA/	AX	W.H. PRESS, et al. "Singular Value Decomposition" NUMERICAL RECIPES IN C, (ISBN 0-521-43108-5), 1988, pgs. 59-70					
/AA/	AY	M. TAKAGI, et al. "Handbook of Image Analysis", (ISBN 4-13-061107-0), 1991, pgs. 548-583					
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner /Andrae Allison/					Date Considered 04/04/2007		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							